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PATENT AND TRADEMARK OFFICE
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Sheet 1 of 1



ATTORNEY DOCKET NO.	SERIAL NO.
45900-000664	09/964,893
APPLICANT	
Claus Erdmann FURST, et al.	
FILING DATE	GROUP
September 28, 2001	Unassigned

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
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2.	EM	4,993,072	2/12/91	Murphy	RE	CEIVED
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2.	EM	"Battery Supplied Low Power Analog-Digital Front-Eng for Audio Applications", R. Klootsema et al.			
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6.	EM	"A Monolithic Surface Micromachined Accelerometer with Digital Output", Crist Lu et al., <u>IEEE International Solid-State</u> <u>Circuits Conference</u> , Session 9, Paper TA9.4, pp. 160-161, 1995.			
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11.	EM	"Optical direct analog-to-digital conversion for microphones", Hitoshi Mada et al., <u>Applied Optics</u> , Vol. 22, No. 21, pp. 3411-3411, November 1, 1983.			

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ATTORNEY DOCKET No. SERIAL NO. FORM HDP-1449 (Based on Form PTO-1449) 45900-000664/US 109/964,893 PATENT AND TRADEMARK OFFICE **APPLICANT** INFORMATION DISCLOSURE CITATION P Claus Erdmann FURST et al. (Use several sheets if necessary) FILING DATE GROUP Sheet 1 of 1 OCT 0 3 2002 2644 September 28, 2001 **U.S. PATENT DOCUMENTS** Examiner's Class/ Ref. Document (If appropriate) Filing Date Desig. Initials Number Date Name Subclass 08/15/2000 381/312 08/28/1997 6,104,821 Husung 4,689,820 08/25/1987 Kopke et al. 381/69 01/28/1983 5,708,720 01/13/1998 Meyer 381/69 10/28/1996 5,757,933 05/26/1998 Preves et al. 381/68.1 12/11/1996

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